



ULN2001LC

LINEAR INTEGRATED CIRCUIT

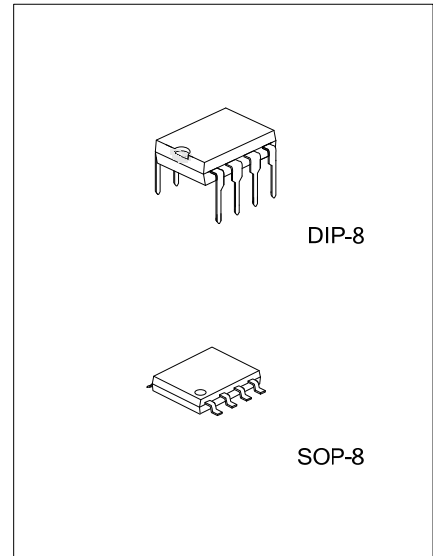
3CH DARLINGTON SINK DRIVER

DESCRIPTION

The UTC **ULN2001LC** is high-voltage, high-current darlington transistor arrays. Each consists of three NPN darlington pairs that feature high-voltage outputs with common-cathode clamp diodes for switching inductive loads. The collector-current rating of a single darlington pair is 100mA. All units feature integral clamp diodes for switching inductive loads.

Applications include relay, hammer, lamp and display (LED) drivers.

The UTC **ULN2001LC** has a 2.7kΩ series base resistor for operation directly with TTL or 5V CMOS devices.



FEATURES

- * Output Current (Single Output): 100mA max
- * High Sustaining Voltage Output: 50V min
- * Inputs Compatible with Various Types of Logic
- * Output Clamp Diodes
- * Relay-Driver Applications

ORDERING INFORMATION

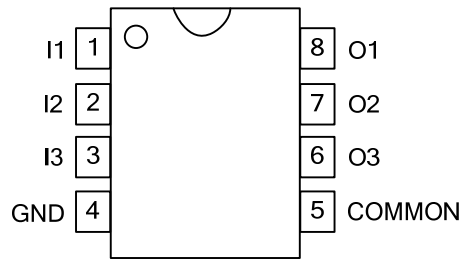
Ordering Number		Package	Packing
Lead Free	Halogen Free		
ULN2001LCL-D08-T	ULN2001LCG-D08-T	DIP-8	Tube
ULN2001LCL-S08-R	ULN2001LCG-S08-R	SOP-8	Tape Reel

<p>ULN2001LCG-D08-T</p> <p>(1) Packing Type (2) Package Type (3) Green Package</p>	<p>(1) T: Tube, R: Tape Reel (2) D08: DIP-8, S08: SOP-8 (3) G: Halogen Free and Lead Free, L: Lead Free</p>
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MARKING

DIP-8	SOP-8

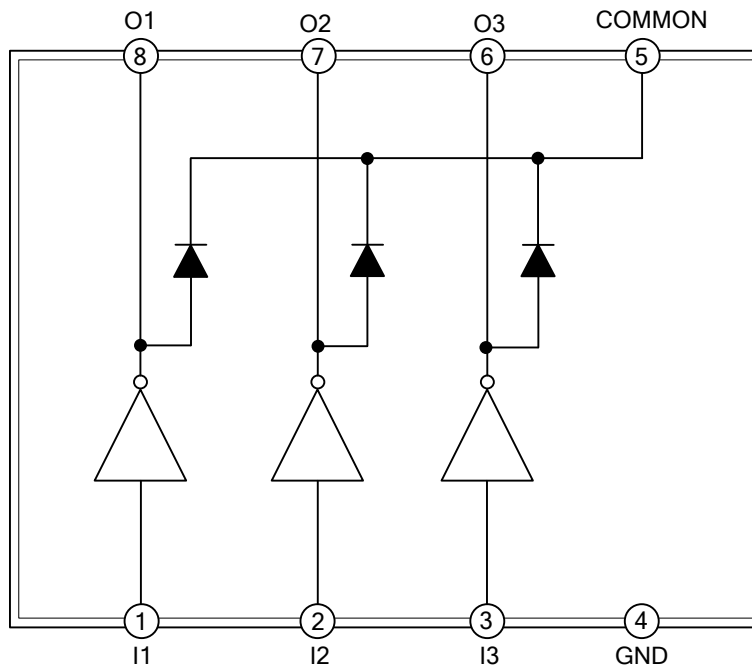
■ PIN CONFIGURATION



■ PIN DESCRIPTION

PIN NO.	PIN NAME	DESCRIPTION
1	I1	1 Channel Input Pin
2	I2	2 Channel Input Pin
3	I3	3 Channel Input Pin
4	GND	Ground
5	COMMON	Clamp Diode
6	O3	3 Channel Output Pin
7	O2	2 Channel Output Pin
8	O1	1 Channel Output Pin

■ BLOCK DIAGRAM



■ ABSOLUTE MAXIMUM RATING ($T_A=25^{\circ}\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Collector-Emitter Voltage		V_{CE}	50	V
Clamp Diode Reverse Voltage		V_{COM}	50	V
Input Voltage		V_I	30	V
Peak Collector Current		I_{CP}	100	mA
Output Clamp Current		I_{OK}	100	mA
Power Dissipation	DIP-8	P_D	0.750	W
	SOP-8		0.625	W
Junction Temperature		T_J	+125	$^{\circ}\text{C}$
Operating Temperature		T_{OPR}	-40 ~ +85	$^{\circ}\text{C}$
Storage Temperature		T_{STG}	-65 ~ +150	$^{\circ}\text{C}$

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS ($T_A=25^{\circ}\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output Sustaining Voltage	$V_{CE(SUS)}$		0		50	V
Output Current	I_{OUT}	$T_A=+85^{\circ}\text{C}$			100	mA/ch
Input Voltage	V_{IN}		0		12	V
Input Voltage (Output On)	$V_{IN(ON)}$	$I_{OUT}=100\text{mA}$	2.8		12	V
Input Voltage (Output Off)	$V_{IN(OFF)}$		0		0.7	V
Clamp Diode Reverse Voltage	V_R				50	V
Clamp Diode Forward Current	I_F				70	mA

■ THERMAL DATA

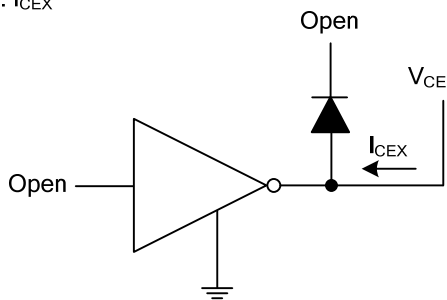
PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	DIP-8	θ_{JA}	133	$^{\circ}\text{C/W}$
	SOP-8		160	$^{\circ}\text{C/W}$

■ ELECTRICAL CHARACTERISTICS (T_A=25°C, unless otherwise specified)

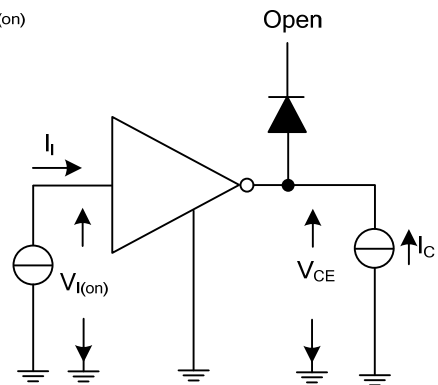
PARAMETER	SYMBOL	TEST CIRCUIT	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Input Voltage (Output On)	V _{I(ON)}	2	V _{CE} =1.5V	I _C =20mA		1.9	2.3	V
				I _C =50mA		2.0	2.4	V
				I _C =80mA		2.0	2.4	V
				I _C =100mA		2.1	2.5	V
Collector-Emitter Saturation Voltage	V _{CE(SAT)}	3	V _I =2.4V (I _I >250μA)	I _C =20mA		0.83		V
				I _C =50mA		0.92		V
				I _C =80mA		0.99		V
				I _C =100mA		1.10		V
Input Current	I _I	2	I _C =60mA	V _I =12V		6.3		mA
				V _I =6V		2.8		mA
				V _I =4.5V		1.97		mA
				V _I =2.4V		0.83		mA
Clamp Diode Forward Voltage	V _F	5	I _F =70mA		1.1	1.4	V	
Output Leakage Current	I _{CEX}	1	V _{CE} =50V, I _I =0			50	μA	
Collector-Emitter Voltage	V _{CE}	1	V _{CE} =50V, I _I =0	50			V	
Clamp Diode Reverse Voltage	V _R	4	V _R =50V	50			V	
Clamp Diode Reverse Current	I _R	4	V _R =50V			50	μA	
Propagation Delay Time, Low- to High	t _{PLH}	6	V _L =12V, R _L =120Ω		0.15	1	μs	
Propagation Delay Time, High - to Low	t _{PHL}	6	V _L =12V, R _L =120Ω		0.15	1	μs	

TEST CIRCUIT

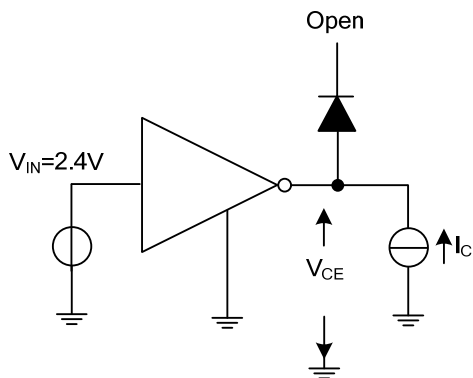
1. I_{CEX}



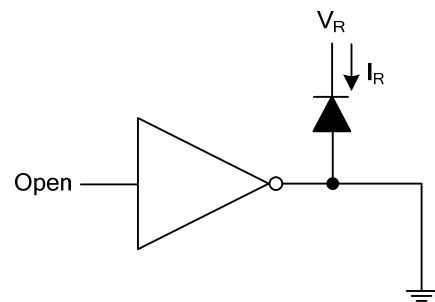
2. I_I & $V_{I(on)}$



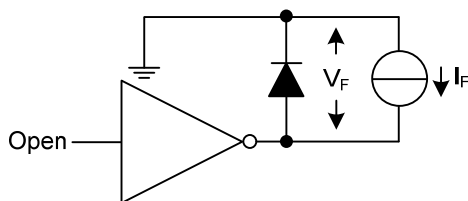
3. $V_{CE(sat)}$



4. I_R

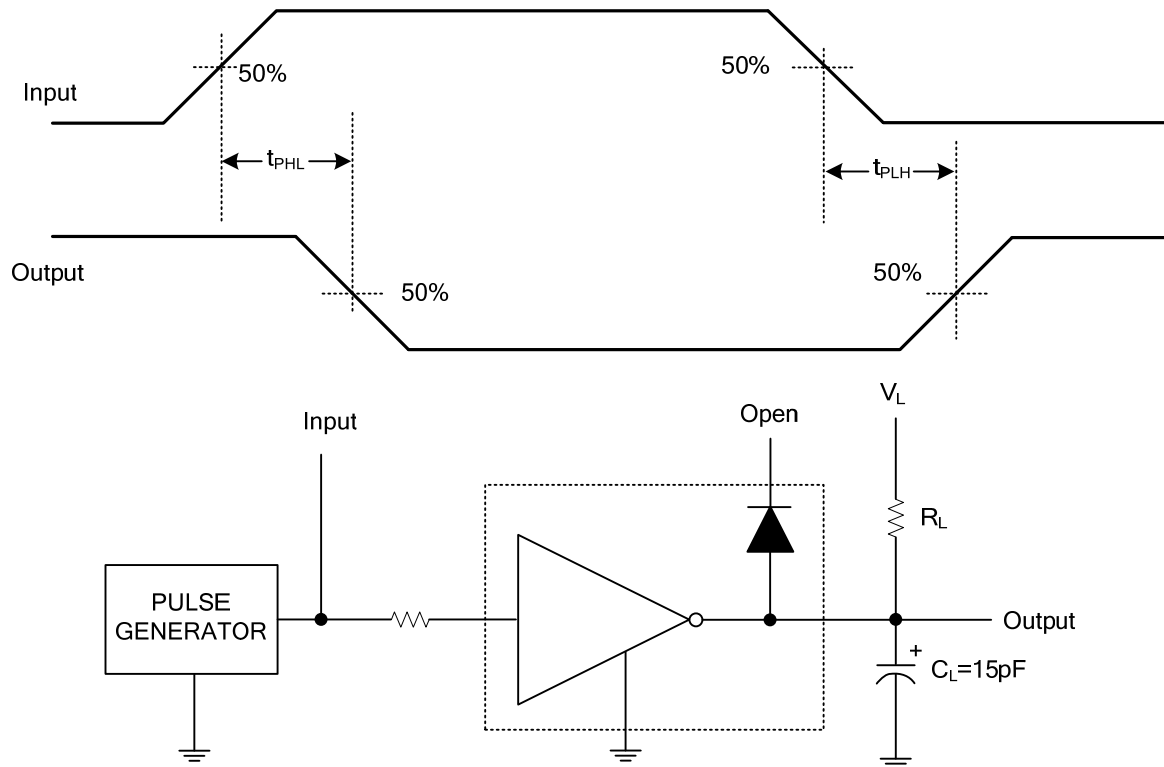


5. V_F

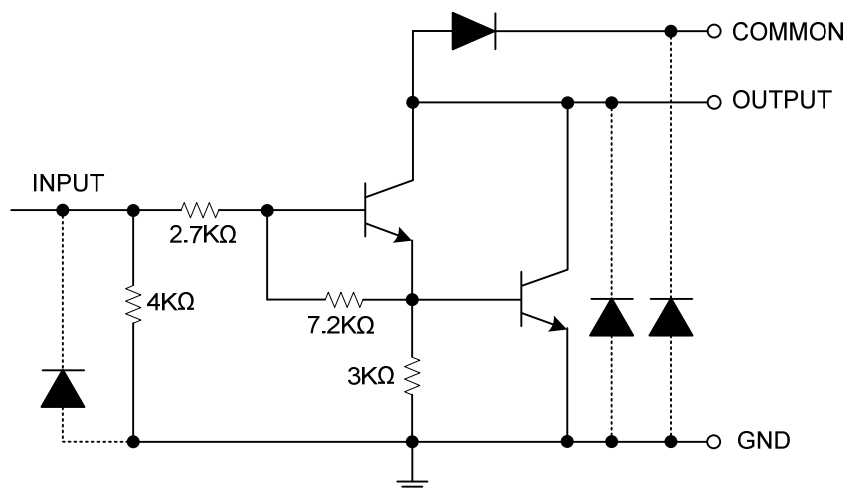


■ TEST CIRCUIT (Cont.)

6. Propagation Delay-Time Waveforms



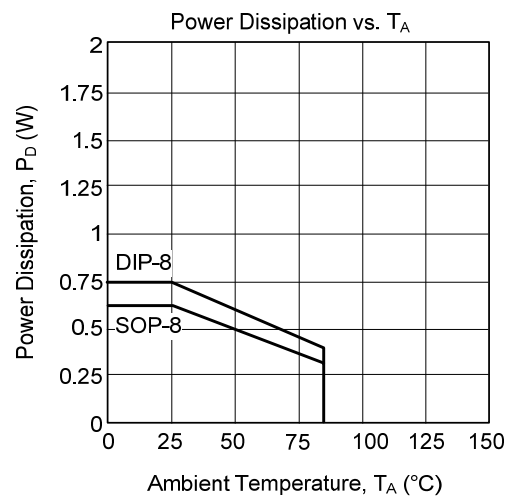
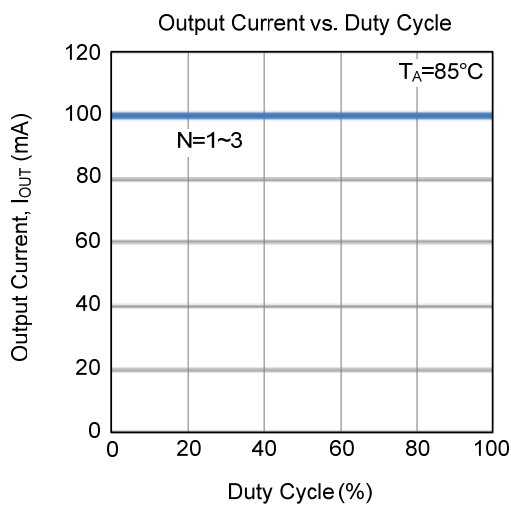
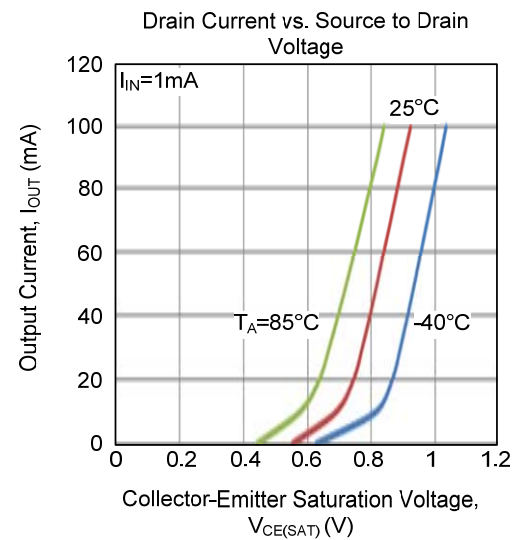
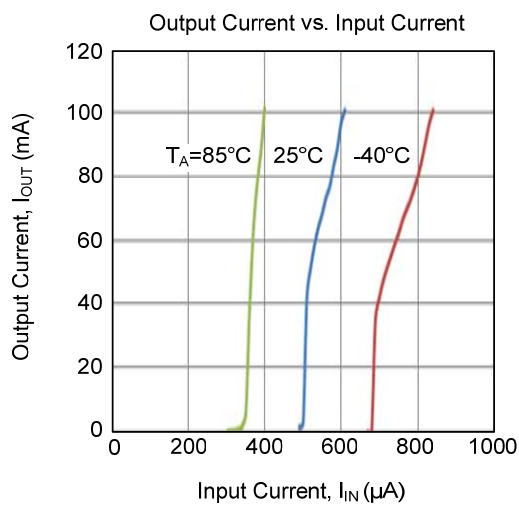
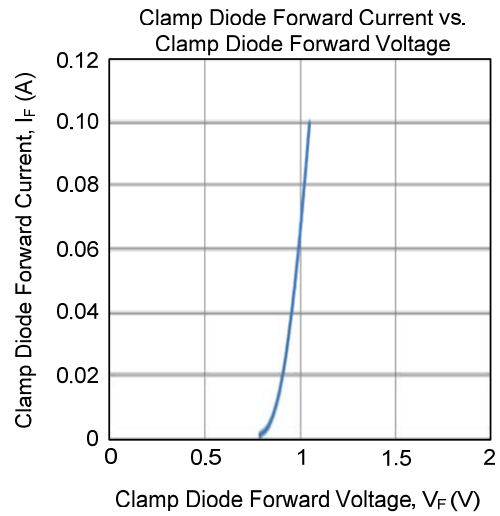
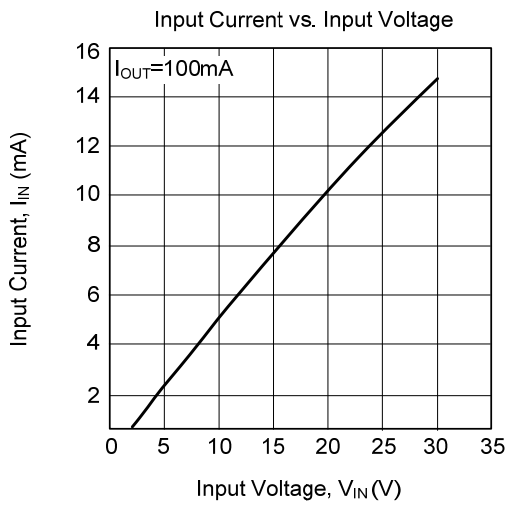
■ TYPICAL APPLICATION CIRCUIT



UTC ULN2001 Drive Circuit

Note: The input and output parasitic diodes cannot be used as clamp diodes.

■ TYPICAL CHARACTERISTICS



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